Surface Composition of SnO₂-ZrO₂ Binary Oxide Catalyst and Its Selectivity for C₃H₆-NO Reaction

Toshinobu Іманака, Takeshi Hashimoto, Katsumi Sakurai, Yasuaki Окамото, and Shiichiro Теканізні*

Department of Chemical Engineering, Faculty of Engineering Science, Osaka University, Toyonaka, Osaka 560 (Received June 12, 1979)

The relation between the composition of outermost surface layer on SnO_2 – ZrO_2 binary oxide catalyst and catalytic selectivity in the C_3H_6 –NO reaction has been investigated by XPS technique. The composition of outermost surface layer was estimated from a comparison of the intensity ratios of X-ray induced Auger peak or XPS peak of Sn to XPS peak of Zr. A superficial enrichment of Zr was observed in these catalysts calcined at 600 °C in the air, while surface enrichment of Sn took place during the course of evacuation at 450 °C. The catalytic selectivity for formation of acrylonitrile showed a maximum with the catalyst containing Sn and Zr in the same concentration at the outermost surface layer of catalyst.

Enrichment of one component of a binary alloy occurs when the alloy is prepared in the air or reactive gases. ^{1,2)} Knowledge of the surface composition of a binary catalyst is necessary for the clarification of heterogeneous catalytic reactions. Only a little evidence of the difference in surface and bulk compositions in cases of multicomponent oxide catalysts has been obtained. ³⁻⁶⁾

Studies with some binary oxide catalysts were carried out by means of X-ray photoelectron spectroscopy (XPS) in order to show the considerable difference occuring in the surface composition from the bulk composition of binary oxide catalysts such as $\rm SnO_2-MoO_3$ and $\rm CoO-MoO_3$ binary systems. $^{7-9)}$ Only a few studies have been made to elucidate the influence of surface composition of solid catalysts on catalytic activity or selectivity. $^{7)}$

In the present work, the relation between the surface composition of some $\mathrm{SnO_2}\text{-}\mathrm{ZrO_2}$ binary oxide catalysts and the catalytic activity or selectivity for the $\mathrm{C_3H_6}\text{-}\mathrm{NO}$ reaction has been studied. Special attention was attached to the role of the outermost surface layer of catalysts on catalytic activity and selectivity.

Experimental

The $\rm SnO_2$ – $\rm ZrO_2$ binary oxide catalysts were prepared by impregnation and coprecipitation. The impregnated catalysts were prepared as follows: Powder of $\rm SnO_2$ or $\rm ZrO_2$ as a support was immersed in aqueous solutions of $\rm ZrO(NO_3)_2$, $\rm ZrOCl_2$, or $\rm SnCl_2$ respectively, followed by evaporation to dryness at 100 °C and calcination in the air at 600 °C for 8 h. The $\rm SnO_2/ZrO_2$ catalyst represents the $\rm SnO_2$ supported on $\rm ZrO_2$, the $\rm ZrO_2/SnO_2$ catalysts representing the $\rm ZrO_2$ supported on $\rm SnO_2$.

Coprecipitated SnO₂–ZrO₂ catalysts were prepared by precipitation at pH~5 from a solution of SnCl₂ and ZrO-(NO₃)₂ or ZrOCl₂ with dilute NH₄OH. The precipitates were washed, dried at 100 °C and then calcined in the air at 600 °C for 8 h. SnCl₂·2H₂O, ZrO(NO₃)₂·2H₂O, ZrO₂ (Nakarai Chemical Co.), ZrOCl₂, SnO₂, and a solution of NH₃ (Wako Pure Chem. Co.) were used.

Procedures

XPS spectra were measured on a Hitachi 507 photoelectron spectrometer equipped with a cylindrical mirror analyzer using Al $K\alpha_{1,2}$ radiation. The cata-

lysts were mounted on a sample holder made of stainless steel. All binding energies were referred to the contaminant carbon [C ls=285.0 eV]. The peak area intensities of Sn $3d_{5/2}$ and Zr 3d were used to obtain the Sn/Zr intensity ratio. The peak of Sn $3d_{5/2}$ (binding energy, B.E., 486.6 ± 0.2 eV) and Sn Auger (LMM, Kinetic energy; K.E., 420 eV) were also used for obtaining information on depth profiles from the surface to the bulk of the catalysts. The surface compositions were determined by the intensity ratio Sn $3d_{5/2}$: Zr 3d or Sn Auger: Zr 3d using the calibration curve obtained by using mixtures of SnO₂ and ZrO₂ powder.

The reaction of $\mathrm{C_3H_6}$ –NO was studied over the $\mathrm{SnO_2}$ – $\mathrm{ZrO_2}$ catalysts by using a reaction mixture, $\mathrm{C_3H_6}/\mathrm{NO}=1/1$, in a circulating system under 2.533×10^4 Pa (190 Torr) total pressure at 530 °C. Products were analyzed by GLC after 3 h.

Results and Discussion

Figure 1 shows the correlation between the content of Sn at the surface and that in bulk of SnO₂–ZrO₂ binary oxide catalysts prepared by coprecipitation.

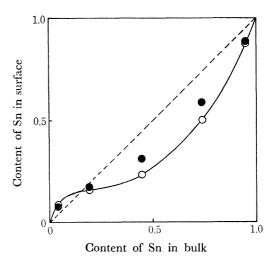


Fig. 1. Correlation between content of Sn in surface and that in bulk for coprecipitated SnO₂-ZrO₂ catalysts.

O: After calcination, ●: after evacuation at 450 °C for 2 h,

The value of surface composition was calculated from the intensity ratio of Sn Auger peak to Zr XPS peak, Zr 3d $(B.E. 181.8\pm0.2 \text{ eV})$. The dotted straight line corresponds to the surface composition equal to bulk composition. A superficial enrichment of Zr was observed in these catalysts calcined in the air except for a small content of Sn (Sn/(Sn+Zr)<0.15 molar)fraction). It is accepted that the surface is enriched by the constituent which has the lowest free energy under a surrounding gas. The surface enrichment of Zr during the course of preparation in the air would be due to the fact that the heat of formation of ZrO₂, 1079.5 kJ mol⁻¹, is larger than that of SnO₂, 574.9 kJ mol-1. If the surface enrichment of Zr can be ascribed to the process in the formation of precipitate, the solubility product constant $K_{\rm sp}$ of $\rm Sn(OH)_2$ should be smaller than that of $Zr(OH)_4$. However, the $K_{\rm sp}$ values of $Sn(OH)_2^{10)}$ and $Zr(OH)_4^{11)}$ are 1.8×10^{-15} and 8×10^{-52} , respectively, at 25 °C. The surface enrichment of Zr cannot be attributed to the difference of solubility in the formation of precipitates. A slight Sn enrichment was observed in the region less than 0.15 mole fraction of Sn in bulk. This might be due to the exclusion of Sn from the bulk of the catalyst by the crystallization of SnO₂. When evacuated at 450 °C for 2 h, the atomic intensity ratio Sn/(Sn+Zr) increased (Fig. 1), indicating that surface enrichment of Sn occurs during the course of evacuation.

The correlations between the content of Sn in surface and that in bulk of $\mathrm{SnO_2-ZrO_2}$ binary catalysts prepared by the impregnation methods are shown in Fig. 2. As expected, the surface enrichment of Sn and Zr was observed in the $\mathrm{SnO_2/ZrO_2}$ and $\mathrm{ZrO_2/SnO_2}$ catalysts, respectively. After evacuation at 450 °C for 2 h, the surface enrichment of Sn was observed in both catalysts.

The surface is enriched by the constituent which has the lowest surface free energy, the surface composition being correlated with the surface tension of solids. Oresbury *et al.*³⁾ pointed out that the surface tension

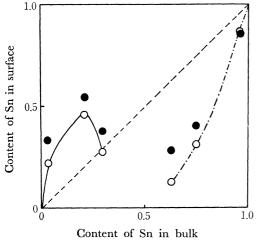


Fig. 2. Correlation between content of Sn in surface and that in bulk for impregnated SnO₂-ZrO₂ catalysts.

O: After calcination, ●: after evacuation at 450 °C for 2 h. —: SnO₂/ZrO₂, —·—: ZrO₂/SnO₂.

of metals can be estimated from the heat of vaporization and sublimation, the surface tension of metals increasing with increase in the heat of vaporization and sublimation. The heat of vaporization of metals is correlated with the melting point of metals, the melting point increasing with increase in the heat of vaporization (cf. Zr: 581.6 kJ mol⁻¹, Sn: 290.4 kJ mol⁻¹). This relation might be applied to binary oxide catalysts. In the case of SnO₂–ZrO₂ binary catalysts, the surface enrichment of Sn seems to be due to the fact that the melting point of SnO₂, 1127 °C, is lower than that of ZrO₂, 2700 °C.¹²⁾ It might also be due to the fact that SnO₂ of the surface is reduced more easily than ZrO₂ since the heat of formation of SnO₂ is lower than that of ZrO₂.

It is necessary to estimate the composition of the outermost surface layer in relation to heterogeneous catalysis. The escape depth increases a great deal with increase in electron energy, characteristic of scattering length determined by electron-electron interactions. The values for the escape depth is evaluated by using samples consisting of homogeneous films having uniform thickness. The intensity, I(d), of photoelectrons with a certain energy, expelled from a film of effective thickness d is given by $I(d)=I_{\infty}[1-\exp{(-d/\lambda)}]$, where λ is the electron escape depth in the film material and I_{∞} the intensity of electrons expelled from a thick sample of the film material.

The energy dependence for the electron escape depth in the energy region of some kilovolts is expressed by the following relation obtained by Brundle, ¹³⁾

$$\lambda(E) \propto E^n$$

where n is 0.5 ± 0.1^{15}) and E the kinetic energy, eV. Accordingly, the value of escape depth of the Sn Auger peak (kinetic energy: 420 eV) is ca. 8 Å, while the Sn XPS peak (kinetic energy: 1000 eV) is estimated to be ca. 12 Å. Thus, information on depth profiles is obtained from a comparison of both peak intensities.

A comparison of surface composition calculated from the intensity ratio of Sn Auger/Zr 3d to that of Sn 3d/Zr 3d is given in Fig. 3. The content of Sn obtained by using Sn Auger peak intensity is represented by r_1 , and the content of Sn determined by Sn $3d_{5/2}$ by r_2 . The surface layer in the impregnated and coprecipitated catalysts seems to be homogeneous. However, after evacuation at 450 °C, the surface enrichment of Sn is observed as shown in Figs. 1 and 2. The results indicate that the surface enrichment of Sn occurs in the surface layer of the SnO₂–ZrO₂ binary oxide catalysts during the course of evacuation at 450 °C.

In the presence of SnO_2 – ZrO_2 catalysts, propylene reacts with NO to give CH_2 =CHCN, CH_3CN , and CO_2 . We have examined the relation between the composition of the outermost surface layer of the catalyst and the catalytic selectivity in this reaction (C_3H_6 –NO).

Figure 4 shows the dependence of catalytic selectivity for the C_3H_6 -NO reaction on the surface composition of the catalysts. In the catalysts prepared by both methods, the change in surface composition obtained from the intensity ratio Sn Auger/Zr 3d was not observed during contact with C_3H_6 , NO, and

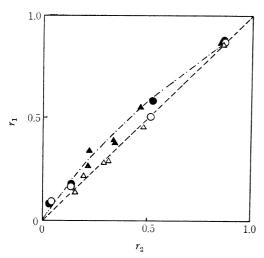


Fig. 3. Depth analysis of Sn in catalyst. r₁: Content of Sn obtained by using Sn Auger intensity, r_2 : content of Sn obtained by using Sn $3d_{5/2}$ intensity.

....., ○: Coprecipitated catalysts,, △: impregnated catalysts: SnO₂/ZrO₂ and ZrO₂/SnO₂.

●,▲: after evacuation at 450 °C for 2 h.

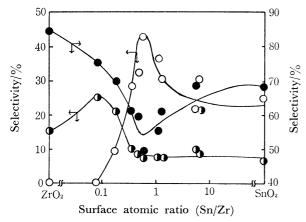
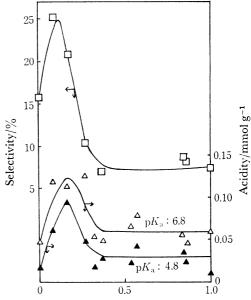


Fig. 4. Selectivity dependence of the reaction (NO+ C₃H₆) on the surface composition of the catalyst. \bigcirc : CH_2 =CHCN, \bigcirc : CH_3CN , \bigcirc : CO_2 . Total pressure: 190 mmHg, Reaction mixtures: C₃H₆/ NO=1/1 Reaction conditions: 530 °C for 3 h.

mixtures of C₃H₆ and NO. The selectivity for the formation of CH₂=CHCN becomes maximum at the atomic ratio, Sn/Zr=0.6, indicating that the catalytic selectivity is a function of surface composition of the catalyst irrespective of the method of preparation. The atomic ratios were estimated from the peak intensities of Sn Auger and Zr XPS, escape depths being 8 Å and 14 Å, respectively. The atomic ratio of Sn to that of Zr in the region near 3 Å from the outermost surface layer, (Sn/Zr)_d, was estimated by using the escape depths of Sn and Zr as follows.

$$\begin{split} (\mathrm{Sn/Zr})_{\mathrm{d}} &= f(I_{\mathrm{sn}}/I_{\mathrm{zr}})_{\mathrm{d}} \\ &= f(I_{\mathrm{sn}}/I_{\mathrm{zr}})_{\infty}[1 - \exp(-d/\lambda_{\mathrm{sn}})]/[1 - \exp(-d/\lambda_{\mathrm{zr}})] \end{split}$$

where d=3 Å, $\lambda_{sn}=8$ Å, $\lambda_{zr}=14$ Å, and f is a constant. The value of atomic ratio in the region near 3 Å from outermost surface layer can thus be estimated by



Surface atomic ratio Sn/(Sn+Zr)

Fig. 5. Correlation between the selectivity for the formation CH₃CN as a function of the atomic ratio on the surface layer of the catalyst and its surface

 \square : Selectivity (%), \triangle : p K_a : 6.8, \blacktriangle : p K_a : 4.8.

 $(Sn/Zr)_3 = 0.96 \approx 1.$

This indicates that the catalytic selectivity for the formation of CH₂=CHCN becomes maximum with the same concentration of Sn and Zr of outermost surface layer on the catalyst.

On the other hand, the selectivity for the formation of CH₃CN becomes maximum near the atomic ratio 0.07 (Fig. 4). The results of acidity (amount of acid mmol/g) measured at p K_a =6.8 and 4.8 and the selectivity for formation of CH₃CN are shown in Fig. 5 as a function of the atomic ratio on the surface layer of the catalyst. The maximum selectivity agrees with that of acidity, indicating that the presence of acid sites on the surface of the catalysts results in the formation of CH₃CN produced by cracking reactions.

References

- 1) V. Ponec, Catal. Rev., 11, 1 (1975).
- 2) J. H. Sinfelt, Acc. Chem. Res., 10, 15 (1977).
- 3) S. H. Oresbury, P. A. Ertrand, and G. H. Somorjai, Chem. Rev., 75, 547 (1975).
- 4) I. Matsuura and M. W. J. Wolfs. J. Catal., 37, 174 (1975).
- 5) B. Grzybowska, J. Haber, W. Marczemski, and L. Unger, J. Catal., 42, 327 (1976).
- 6) T. S. R. Prasada Rao and P. G. Menon, J. Catal., **51**, 64 (1978).
- 7) Y. Okamoto, T. Hashimoto, T. Imanaka, and S.
- Teranishi, Chem. Lett., 1978, 1035.

 8) Y. Okamoto, T. Shimokawa, T. Imanaka, and S. Teranishi, J. Chem. Soc., Chem. Commun., 1978, 47.
- 9) Y. Okamoto, T. Shimokawa, T. Imanaka, and S. Teranishi, J. Catal., 57, 153 (1979).
- 10) "Solubilities of Inorganic and Organic Compounds, Binary Systems, Part I." Pergamon Press Ltd., (1963), Vol. 1, p. 43 ($K_{\rm sp}$ was calculated from the solubilities).

- 11) "Solubilities of Inorganic Compounds," American Chemical Society, Washington D. C. (1958), Vol. 2, p. 1695.
- 12) On the other hand, solid stannous oxide formed in a vacuum is unstable and decomposes into Sn and SnO2, the treatment of the catalyst in a vacuum thus resulting in the segregation of Sn reduced on the surface layer. T. C. Platteauw and G. Meyer, Trans. Faraday Soc., 52, 1066

(1956).

- 13) C. R. Brundle, Surf. Sci., 48, 99 (1975).
 14) M. Klasson A. Berndtsson, J. Hedman, R. Nilsson, R. Nyholm, and C, Nordling, J. Electon Spectrosc. Relat. Phenom. 3, 427 (1974).
- 15) M. Klasson, J. Hedman, A. Berndtsson, R. Nilsson, C. Nordling, and P. Melnik, Phys. Sci., 5, 93 (1972).